

Docket No.: 4481-045



RS

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1-22-03
PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

David Finlay TAYLOR et al.

Serial No. 10/084,498

Group Art Unit: 2631

Filed: February 28, 2002

Examiner: UNKNOWN

For: NETWORK MEASUREMENT METHOD AND APPARATUS

INFORMATION DISCLOSURE STATEMENT

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APR 26 2002
Technology Center 2600

Commissioner for Patents
Washington, D. C. 20231

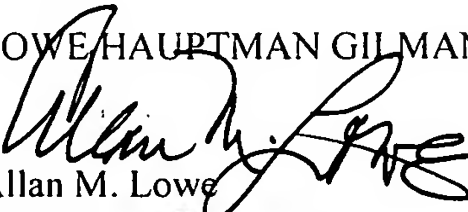
Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Respectfully submitted,

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| INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449) | ATTY. DOCKET NO. 4481-045 | SERIAL NO. 10/084,498 |
| | APPLICANT David Finlay TAYLOR et al | |
| | FILING DATE February 28, 2002 | GROUP 2631 |

U.S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | NAME | CLASS | SUBCLASS | FILING DATE |
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FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | COUNTRY | CLASS | SUBCLASS | Translation | |
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| | 1 152 562 A1 | 07.11.2001 | EP | | | | |
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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| EXAMINER | DATE CONSIDERED |
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.